## Application/Control No. Applicant(s)/Patent Under Reexamination 10/661,560 YOKOTA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Nguyen N. Hanh 2834 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-5,847,903 12-1998 Ogawa et al. 360/264.8 US-В US-С US-D US-Ε F US-US-G USн ı US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν GB 2 209 878 05-1989 GB Roger F. Baines H02K 23/40 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.